Notice of References Cited Application/Control No. 09/409,644 Examiner Arlen Soderquist Applicant(s)/Patent Under Reexamination LEWIS ET AL. Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,636,767	01-1987	Barger et al.	338/34
*	В	US-5,926,360	07-1999	Laibowitz et al.	361/321.4
*	С	US-6,202,471	03-2001	Yadav et al.	73/31.05
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Η	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	C	Collins, R. A. et al, Thin Solid Films 1986, 145, 133-145.
	>	Kurtzler, F. W. et al, Thin Solid Films 1987, 155, 1-16.
	w	Wilson, A. et al, Sensors and Actuators 1987, 12, 389-403.
	×	Haugen, G. et al, Analytical Chemistry 1988, 60, 23A-31A.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 09/409,644 Examiner Art Unit Arlen Soderquist Applicant(s)/Patent Under Reexamination LEWIS ET AL. Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
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	D	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Grate, J. W. et al, Langmuir 1988, 4, 1293-1301.
	>	Temofonte, T. A. et al, Journal of Applied Physics 1989, 65, 1350-1355.
	w	Belanger, D. et al, Analytica Chimica Acta 1990, 228, 311-315.
	х	Brina, R. et al, Analytical Chemistry 1990, 62, 2357-2365.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 09/409,644 Examiner Arlen Soderquist Applicant(s)/Patent Under Reexamination LEWIS ET AL. Page 3 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
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	G	US-			
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	K	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	C	Takada, J. et al, Applied Physics Letters 1992, 61, 2184-2186.
	>	Collins, G. E. et al, Journal of Vacuum Science and Technology A 1993, 11, 1383-1391.
	W	Charlesworth, J. M. et al, Journal of Physical Chemistry 1993, 97, 5418-5423.
	x	Marsella, M. J. et al, Journal of the American Chemical Society 1995, 117, 9832-9841.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 09/409,644 Examiner Art Unit Arlen Soderquist Applicant(s)/Patent Under Reexamination LEWIS ET AL. Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	O	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U	Ellis, D. L. et al, Analytical Chemistry 1996, 68, 817-822.					
	٧	Grate, J. W. et al, Chemistry of materials 1997, 9, 1201-1207.					
	w	Dyer, D. C. et al, Sensors and Actuators A 1997, 62, 724-728.					
	x						

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.